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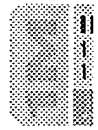
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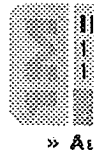
1 Parallel Solution Algorithms for the Triangular Sylvester Equation
Gerasoulis, A.; Nelken, I.;

Distributed Memory Computing Conference, 1990., Proceedings of the Fifth , / 8-12, 1990

Pages:291 - 300

[\[Abstract\]](#) [\[PDF Full-Text \(636KB\)\]](#) **IEEE CNF**
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1 Application of the adaptive impulse correlated filter for recovering f electrocardiogram

 Martinez, M.; Soria, E.; Calpe, J.; Guerrero, J.F.; Magdalena, J.R.;
Computers in Cardiology 1997 , 7-10 Sept. 1997
Pages:9 - 12

[\[Abstract\]](#) [\[PDF Full-Text \(300KB\)\]](#) IEEE CNF

2 Toll-quality digital secraphone

 Calpe, J.; Magdalena, J.R.; Guerrero, J.F.; Frances, J.V.;
Electrotechnical Conference, 1996. MELECON '96., 8th Mediterranean ,Volum
3 , 13-16 May 1996
Pages:1714 - 1717 vol.3

[\[Abstract\]](#) [\[PDF Full-Text \(336KB\)\]](#) IEEE CNF

3 NEMESIS: a new telemedicine approach to cardiologic software

 Magdalena, J.R.; Soria, E.; Serrano, A.; Calpe, J.; Guerrero, J.; Martinez, M.;
Computers in Cardiology 1999 , 26-29 Sept. 1999
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1 LET dependence of the charge collection efficiency of silicon microdosimeters
Cornelius, I.M.; Rosenfeld, A.B.; Siegele, R.; Cohen, D.D.;
 Nuclear Science, IEEE Transactions on ,Volume: 50 , Issue: 6 , Dec. 2003
 Pages:2373 - 2379

[\[Abstract\]](#) [\[PDF Full-Text \(853KB\)\]](#) **IEEE JNL**
2 Simplified control of FFT hardware
Cohen, D.;
 Acoustics, Speech, and Signal Processing [see also IEEE Transactions on Signal Processing], IEEE Transactions on ,Volume: 24 , Issue: 6 , Dec 1976
 Pages:577 - 579

[\[Abstract\]](#) [\[PDF Full-Text \(296KB\)\]](#) **IEEE JNL**
3 Spectrum Management of the HF Broadcasting Service After WARC-
Cohen, D.; Rush, C.;
 Communications, IEEE Transactions on [legacy, pre - 1988] ,Volume: 29 , Issue: 8 , Aug 1981
 Pages:1151 - 1155

[\[Abstract\]](#) [\[PDF Full-Text \(528KB\)\]](#) **IEEE JNL**
4 Modeling Thermal Characteristics of a Fixed Disk Drive
Eibeck, P.; Cohen, D.;
 Components, Hybrids, and Manufacturing Technology, IEEE Transactions on [see also IEEE Trans. on Components, Packaging, and Manufacturing Technology, I A, B, C] ,Volume: 11 , Issue: 4 , Dec 1988
 Pages:566 - 570

[\[Abstract\]](#) [\[PDF Full-Text \(664KB\)\]](#) **IEEE JNL**
5 Operational amplifier integrators for the measurement of the delay times of microwave transistors
Cohen, D.D.; Zakarevicius, R.A.;

Solid-State Circuits, IEEE Journal of , Volume: 10 , Issue: 1 , Feb 1975
Pages:19 - 27

[\[Abstract\]](#) [\[PDF Full-Text \(1392KB\)\]](#) IEEE JNL

6 Measurements of the magnetic fields produced by the human heart, brain, and lungs

Cohen, D.;

Magnetics, IEEE Transactions on , Volume: 11 , Issue: 2 , Mar 1975

Pages:694 - 700

[\[Abstract\]](#) [\[PDF Full-Text \(872KB\)\]](#) IEEE JNL

7 Review of measurements of magnetic fields produced by natural i n currents in humans

Cohen, D.;

Magnetics, IEEE Transactions on , Volume: 6 , Issue: 2 , Jun 1970

Pages:344 - 345

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8 Sensitivity and scattering in a monolithic heterodyned laser biochen sensor

Cohen, D.A.; Nolde, J.A.; Pedretti, A.T.; Wang, C.S.; Skogen, E.J.; Coldren, L.

Selected Topics in Quantum Electronics, IEEE Journal of , Volume: 9 , Issue:

5 , Sept.-Oct. 2003

Pages:1124 -1131

[\[Abstract\]](#) [\[PDF Full-Text \(528KB\)\]](#) IEEE JNL

9 Improvement of SOI microdosimeter performance using pulse-shap discrimination techniques

Cornelius, I.; Rosenfeld, A.; Siegele, R.; Cohen, D.;

Nuclear Science, IEEE Transactions on , Volume: 49 , Issue: 6 , Dec. 2002

Pages:2805 - 2809

[\[Abstract\]](#) [\[PDF Full-Text \(648KB\)\]](#) IEEE JNL

10 Relative intensity noise measurements of a widely tunable samplec grating DBR laser

Hanxing Shi; Cohen, D.; Barton, J.; Majewski, M.; Coldren, L.A.; Larson, M.C.

Fish, G.A.;

Photonics Technology Letters, IEEE , Volume: 14 , Issue: 6 , June 2002

Pages:759 - 761

[\[Abstract\]](#) [\[PDF Full-Text \(187KB\)\]](#) IEEE JNL

11 Paying for the Internet in the new millennium

Cohen, D.;

Internet Computing, IEEE , Volume: 4 , Issue: 1 , Jan.-Feb. 2000

Pages:56 - 58

[\[Abstract\]](#) [\[PDF Full-Text \(216KB\)\]](#) IEEE JNL

12 Phased-array optically controlled receiver using a serial feed

Tsap, B.; Yian Chang; Fetterman, H.R.; Levi, A.F.J.; Cohen, D.A.; Newberg, I.
Photonics Technology Letters, IEEE ,Volume: 10 , Issue: 2 , Feb. 1998
Pages:267 - 269

[\[Abstract\]](#) [\[PDF Full-Text \(104KB\)\]](#) [IEEE JNL](#)

13 Optically controlled serially fed phased-array transmitter

Chang, Y.; Tsap, B.; Fetterman, H.R.; Cohen, D.A.; Levi, A.F.J.; Newberg, I.L.
Microwave and Guided Wave Letters, IEEE [see also IEEE Microwave and Wire
Components Letters] ,Volume: 7 , Issue: 3 , March 1997
Pages:69 - 71

[\[Abstract\]](#) [\[PDF Full-Text \(76KB\)\]](#) [IEEE JNL](#)

14 The AETG system: an approach to testing based on combinatorial d

Cohen, D.M.; Dalal, S.R.; Fredman, M.L.; Patton, G.C.;
Software Engineering, IEEE Transactions on ,Volume: 23 , Issue: 7 , July 199
Pages:437 - 444

[\[Abstract\]](#) [\[PDF Full-Text \(364KB\)\]](#) [IEEE JNL](#)

15 Passive temperature compensation of uncooled GaInAsP-InP diode lasers using thermal stress

Cohen, D.A.; Coldren, L.A.;
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2 , April 1997
Pages:649 - 658

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Cohen, D.A.; Nolde, J.A.; Pedretti, A.T.; Wang, C.S.; Skogen, E.J.; Coldren, L.
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2 Phased-array optically controlled receiver using a serial feed

Tsap, B.; Yian Chang; Fetterman, H.R.; Levi, A.F.J.; Cohen, D.A.; Newberg, I.
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3 Optically controlled serially fed phased-array transmitter

Chang, Y.; Tsap, B.; Fetterman, H.R.; Cohen, D.A.; Levi, A.F.J.; Newberg, I.L.
 Microwave and Guided Wave Letters, IEEE [see also IEEE Microwave and Wire Components Letters] , Volume: 7 , Issue: 3 , March 1997
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Cohen, D.A.; Coldren, L.A.;
 Selected Topics in Quantum Electronics, IEEE Journal of , Volume: 3 , Issue: 2 , April 1997
 Pages:649 - 658

[\[Abstract\]](#) [\[PDF Full-Text \(228KB\)\]](#) **IEEE JNL**
5 Integrati n f semic nduct r laser amplifiers with sampled grating tunable lasers f r WDM applicati ns

San-Liang Lee; Heimbuch, M.E.; Cohen, D.A.; Coldren, L.A.; DenBaars, S.P.;

Selected Topics in Quantum Electronics, IEEE Journal of , Volume: 3 , Issue: 2 , April 1997
Pages:615 - 627

[\[Abstract\]](#) [\[PDF Full-Text \(288KB\)\]](#) IEEE JNL

6 Optically controlled serially fed phased array sensor

Cohen, D.A.; Yian Chang; Levi, A.F.J.; Fetterman, H.R.; Newberg, I.L.;
Photonics Technology Letters, IEEE , Volume: 8 , Issue: 12 , Dec. 1996
Pages:1683 - 1685

[\[Abstract\]](#) [\[PDF Full-Text \(324KB\)\]](#) IEEE JNL

7 High quantum efficiency and narrow absorption bandwidth of the w. fused resonant $\text{In}_{0.53}\text{Ga}_{0.47}\text{As}$ photodetectors

I-Hsing Tan; Dudley, J.J.; Babic, D.I.; Cohen, D.A.; Young, B.D.; Hu, E.L.; Bo J.E.; Miller, B.I.; Koren, U.; Young, M.G.;
Photonics Technology Letters, IEEE , Volume: 6 , Issue: 7 , July 1994
Pages:811 - 813

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